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# Direct and Indirect Interlayer Excitons in a van der Waals Heterostructure of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/ hBN

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**(5)** Supporting Information

**ABSTRACT:** A van der Waals (vdW) heterostructure composed of multivalley systems can show excitonic optical responses from interlayer excitons that originate from several valleys in the electronic structure. In this work, we studied photoluminescence (PL) from a vdW heterostructure,  $WS_2/MoS_2$ , deposited on hexagonal boron nitride (hBN) flakes. PL spectra from the fabricated heterostructures observed at room temperature show PL peaks at 1.3–1.7 eV, which are absent in the PL spectra of  $WS_2$  or  $MoS_2$  monolayers alone. The low-energy PL peaks we observed can be decomposed into three distinct peaks. Through detailed PL measurements and theoretical analysis, including PL imaging, time-



resolved PL measurements, and calculation of dielectric function  $\varepsilon(\omega)$  by solving the Bethe–Salpeter equation with  $G_0W_0$ , we concluded that the three PL peaks originate from direct K–K interlayer excitons, indirect Q– $\Gamma$  interlayer excitons, and indirect K– $\Gamma$  interlayer excitons.

**KEYWORDS:** transition metal dichalcogenides, van der Waals heterostructures, interlayer exciton, photoluminescence spectroscopy, density functional theory

wo-dimensional (2D) van der Waals (vdW) heterostructures, particularly those based on transition metal dichalcogenides (TMDs), offer opportunities to explore electronic and optical properties at the two-dimensional limit.<sup>1–5</sup> TMDs possess layered structures in which a transition metal layer is sandwiched by chalcogen layers with trigonal prismatic or octahedral geometries.<sup>6-10</sup> These layers are stacked to form bulk crystals of TMDs. Importantly, TMDs can be isolated in monolayer form owing to the weak interlayer vdW force.<sup>1,7,9</sup> Recent studies have shown that monolayer TMDs, three-atom-thick atomic layers, can be assembled into vdW heterostructures with desired sequences.<sup>11-14</sup> Although further development of fabrication methods is still necessary to achieve vdW heterostructures with fully controllable stacking sequences, these results suggest the exciting possibility of designing heterostructure 2D systems with customizable electronic band structures and physical properties.

The emergence of interlayer excitons in type-II vdW heterostructures of TMDs provides an opportunity to explore the basic physics of 2D excitons and valley degree of freedom

(VDOF).<sup>2,3,15</sup> Monolayer TMDs in the 2H phase have hexagonal honeycomb frameworks, where A- and B-sites are occupied by transition metal and chalcogen atoms, respectively.<sup>10,16</sup> 2H-TMDs possess two inequivalent valleys in their electronic bands at the corners of their hexagonal Brillouin zones (K and K' points), and the inequivalent K and K' points are the source of the VDOF.<sup>8,17</sup> In monolayer semiconductor TMDs, such as WS<sub>2</sub> and MoS<sub>2</sub>, the K and K' points correspond to direct energy gaps.<sup>18</sup> Due to the enhanced many-body effect in 2D systems, strong excitonic transitions can be observed even at room temperature. Furthermore, in TMDs with an odd number of TMD layers, excitation by circular-polarized light can create photoexcited carriers selectively at K or K' points, thus yielding valley-polarized 2D excitons.<sup>17,19,20</sup> These fascinating properties of TMDs can also be observed in vdW heterostructures composed of TMDs.<sup>2,3</sup> Recent works on TMD

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Figure 1. (a) Structural model of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN. Magenta, cyan, yellow, blue, and pink spheres represent tungsten, molybdenum, sulfur, nitrogen, and boron atoms, respectively. (b) Typical Raman spectrum from hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN. (c) PL image of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN. This image combines transmission bright-field image (monochrome), 1.97-2.07 eV (magenta), and 1.71-1.91 eV detection (cyan). Magenta and cyan lines show the edge of WS<sub>2</sub> and MoS<sub>2</sub> crystals, respectively. To measure both the Raman spectrum and PL image, an excitation energy of 2.54 eV was used.

vdW heterostructures with type-II band alignment have shown that interlayer excitons, which have electrons and holes located in different layers, can be formed in such systems.<sup>1,12,21,22</sup> Compared with intralayer excitons,<sup>20,23,24</sup> interlayer excitons can have very long lifetimes (~138 ns) and valley depolarization lifetimes (~39 ns).<sup>2,22</sup> Therefore, TMD vdW heterostructures with type-II band alignment provide an excellent platform to explore exotic 2D many-body excitonic states and introduce the potential of realizing valleytronic devices.

Exploration of basic exciton physics and the possibility for optoelectronic applications of a TMD-based type-II vdW heterostructure requires deeper understanding of the interlayer excitons that emerge in this system. TMDs are multivalley semiconductors in which intra- and intervalley excitons (electrons and holes located at the same or different valleys) can be formed by optical excitation.<sup>17,20</sup> When used in heterostructures, interlayer interactions can cause changes in electronic bands accompanied by shifts in the energies of the valence band maximum (VBM) and the conduction band minimum (CBM). Under this condition, other valleys, including  $\Gamma$  and Q valleys, can contribute to optical transitions along with the contributions from K and K'.<sup>21,25,26</sup> Furthermore, TMD-based heterostructures with different stacking angles can have different electronic band structures, where the CBM and VBM are located at different positions.<sup>26</sup> Therefore, various kinds of interlayer excitons can appear in TMD-based heterostructures, and these interlayer excitons can cause a range of optical responses.<sup>21,27,28</sup> For example, direct and indirect interlayer excitons can form in TMD-based heterostructures through Coulomb interaction between electrons and holes located at various valleys. Direct and indirect interlayer excitons should show different exciton lifetimes and can carry VDOF differently, providing a range of optical responses in heterostructures. Photoluminescence (PL) peaks in a WS<sub>2</sub>/MoS<sub>2</sub> heterostructure have been reported to originate from interlayer excitons corresponding to K-K and K- $\Gamma$ transitions;<sup>29</sup> however, further spectroscopic characterization and theoretical analysis are necessary to fully elucidate the origin of these PL emissions.

Here, we report observations of three different interlayer excitons in PL spectra of a  $WS_2/MoS_2$  heterostructure with type-II band alignment.<sup>25,30</sup> We use hexagonal boron nitride (hBN) flakes as a substrate and apply an overlayer to form an hBN-encapsulated  $WS_2/MoS_2$  sample (*i.e.*, hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN) to observe fine structures in the heterostructure's optical

spectra. hBN is a layered insulator without dangling bonds on the surface, and hBN can protect  $WS_2/MoS_2$  from substrate effects such as the inhomogeneous broadening in the optical transitions that are caused by surface roughness.<sup>31,32</sup> In addition, we have, importantly, controlled the stacking angle in WS<sub>2</sub>/MoS<sub>2</sub>. As mentioned above, the electronic band structure of  $WS_2/MoS_2$  depends on the stacking angle. Therefore, controlling the stacking angle is necessary to ascertain the origin of interlayer excitons. In previous studies, second-harmonic generation microscopy, which requires an ultrashort pulsed light source, was used for preparing the stacking-angle-controlled samples.<sup>2</sup> In this work, we report the development of a simple alternative dry-transfer-stamping technique with TMD crystals grown by chemical vapor deposition (CVD). The CVD-grown crystals typically have faceted zigzag edges,<sup>33,34</sup> which indicate the crystal orientation during the transfer process, and we can easily and unambiguously control relative orientation between WS2 and MoS<sub>2</sub> in a heterostructure. In a typical PL spectrum of hBN/  $WS_2/MoS_2/hBN$  with a stacking angle of ~60°, we have observed three contributions in the energy region of 1.3-1.7eV at room temperature. By comparing photoluminescence excitation (PLE) measurements and theoretical calculations, we have concluded that the three contributions originate from the following: (1) direct K–K interlayer excitons, (2) indirect Q– $\Gamma$ interlayer excitons, and (3) K- $\Gamma$  interlayer excitons. These findings provide a basis for further understanding the optical physics of TMD-based heterostructures.

#### **RESULTS AND DISCUSSION**

The heterostructure samples studied (hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN) are prepared following the dry-transfer method with CVDgrown TMDs. First, we prepared WS<sub>2</sub>/sapphire and MoS<sub>2</sub>/ hBN monolayers by CVD with a multifurnace CVD setup. Elemental sulfur is used as the sulfur source in both cases, and tungsten that was sputtered on sapphire and MoO<sub>3</sub> are used as the metal source while growing the  $WS_2$ /sapphire and  $MoS_2$ / hBN layers, respectively. The monolayer structure of the grown WS<sub>2</sub> and MoS<sub>2</sub> sheets was confirmed with an optical microscope and PL spectroscopy, respectively (Figure S1). Both contrast in optical images and PL peaks of monolayers are distinctly different from those of multilayers, leading to easy and sure confirmation of the monolayer structure. The crystal of monolayer WS<sub>2</sub> grown on a sapphire substrate was subsequently transferred to an hBN flake mounted on a poly(methyl methacrylate) (PMMA)/polydimethylsiloxane



Figure 2. (a) PL spectra of hBN/WS<sub>2</sub>/hBN, hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN, and hBN/MOS<sub>2</sub>/hBN measured at room temperature. An excitation energy of 2.54 eV was used to measure all spectra. (b) PL spectrum of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN at lower energy side with excitation energy of 2.33 eV. Contributions from  $I_1$ ,  $I_2$ , and  $I_3$ , which are plotted with green, orange, and red curves, respectively, are modeled by a Voigt function.

(PDMS) film, after which the WS<sub>2</sub> on the hBN/PMMA/PDMS was placed onto a MoS<sub>2</sub>/hBN crystal to form the hBNencapsulated heterostructure, hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN. After the transfer process, samples were heated at 200 °C for more than 10 h to ensure good physical contact between WS<sub>2</sub> and MoS<sub>2</sub>. The postheating process has been proven to be important to make good physical contact between layers in a van der Waals heterostructure.<sup>35</sup> Figure 1a-c shows a schematic of hBN/ WS<sub>2</sub>/MoS<sub>2</sub>/hBN, a typical Raman spectrum, and a typical PL image. The Raman spectrum of a hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN with a 60° stacking angle (Figure 1b) shows four peaks at 356.7, 384.6, 405.7, and 418.6 cm<sup>-1</sup>, which are consistent with the peaks observed in the Raman scattering from the E' and A'\_1 modes of monolayer  $MoS_2$  and  $WS_2$ .<sup>12–14</sup> As seen in the PL image (Figure 1c), PL is strongly quenched at the stacked region, which indicates that interlayer charge transfer is occurring efficiently across the interface between the layers.<sup>14,36</sup>

This clean interface was also confirmed with low-frequency Raman spectroscopy. In a low-frequency Raman spectrum (Figure S2), the shear and breathing interlayer vibrational modes are clearly seen at 23.7 and 35.5 cm<sup>-1</sup>, respectively. These interlayer modes require strong layer–layer coupling in WS<sub>2</sub>/MoS<sub>2</sub>, thus indicating that the interface between the monolayers is clean.<sup>37</sup> Therefore, the full dry-transfer method we used can produce a clean heterostructure interface.

To further characterize the heterostructure, we measured the PL spectrum at room temperature with 2.54 eV excitation energy and  $3 \times 10^2$  W/cm<sup>2</sup> input power. Figure 2a shows the PL spectrum, where PL emissions from intralayer excitons in the WS<sub>2</sub> and MoS<sub>2</sub> samples can be seen at 2.00 and 1.88 eV, respectively.<sup>7,12,33</sup> In addition, the heterostructure produces additional PL peaks at energies significantly lower than those of intralayer excitons, which are in the range of 1.3-1.7 eV. These additional peaks occur only in heterostructure samples,<sup>12,29</sup> and we hypothesize that these peaks correspond to emissions from interlayer excitons. Peak decomposition analysis of the additional peaks (Figure 2b) has revealed the existence of three peaks at 1.63, 1.52, and 1.44 eV, which are respectively referred to as I1, I2, and I3 in the following discussion. We prepared several heterostructure samples with a stacking angle of  $\sim 60^{\circ}$  as discussed above, and the interlayer exciton peaks appear in the PL spectra in all cases (Figures S3 and S4); peak positions of  $I_1 - I_3$  slightly change depending on samples, and statistics on the peak positions are shown in Figure S4. We also prepared heterostructure samples with stacking angles from 0 to 30°. In these samples, the peak positions and appearance of  $I_1 - I_3$  depend on the stacking angle (Figure S5). These results

are consistent with the hypothesis that these peaks originate from interlayer excitons.<sup>12,13,27</sup> Note that the  $I_1$ – $I_3$  peaks merge into a single broad peak in previously reported PL spectra of WS<sub>2</sub>/MoS<sub>2</sub> probably due to inhomogeneous broadening caused by the substrate.<sup>12</sup> This achievement over previous results clearly demonstrates that the hBN encapsulation structure used in this study suppresses inhomogeneous broadening to obtain sufficiently fine-grain spectra data from the heterostructure itself.

To exclude the possibility that  $I_1-I_3$  originate from bound excitons trapped at impurities or defect sites, we also measured exciton diffusion lengths through observations of PL images. The diffusion length of bound excitons should be nearly zero because bound excitons are localized around defects, while free excitons can diffuse over several hundred nanometers or even micrometers.<sup>38,39</sup> Figure 3a,b shows a PL image of WS<sub>2</sub>/MoS<sub>2</sub>



Figure 3. (a) Typical PL image of  $I_3$  in hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN excited by 2.43 eV light. White dotted line marks the edge of the sample. The inset shows the laser profile. (b) Cross-sectional profile of the PL image of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN and excitation laser (instrument response function, IRF).

and its corresponding cross-sectional profile, respectively. The PL image was taken with photon energy less than 1.51 eV (region of  $I_3$ ) at room temperature. The inset of Figure 3a is an image of the laser beam used to excite the sample, and its corresponding cross-sectional profile is also shown in Figure 3b; excitation energy of 2.43 eV was used. It can be clearly observed that the PL image is broader than that of the corresponding excitation laser beam; this suggests that excitons created by the incident photons diffuse along the 2D plane. The PL image includes broadening arising not only from exciton diffusion but also from the laser spot size and the diffraction limit. Under the assumption that the broadening from the laser spot and the diffraction limit can be modeled as a Gaussian function, we have fitted the line profile of the PL image with the



Figure 4. (a) DFT band structure of WS<sub>2</sub>/MoS<sub>2</sub> heterostructure. Projections of bands onto individual layers are shown with a color gradient map. (b) Imaginary part of the dielectric function  $\varepsilon(\omega)$  obtained by solving the Bethe–Salpeter equation with  $G_0W_{0\nu}$  depicting the optical absorption spectrum of WS<sub>2</sub>/MoS<sub>2</sub> heterostructure (middle) along with the spectra from monolayer MoS<sub>2</sub> (top) and WS<sub>2</sub> (bottom). Vertical bars denote calculated oscillator strengths at the transition energy. The relative angle of 60° and the AA' stacking configuration are used in this calculation.

following diffusion equation (see Supporting Information for details):

$$\frac{\partial N}{\partial t} = D \left( \frac{\partial^2 N}{\partial x^2} + \frac{\partial^2 N}{\partial y^2} \right) - \frac{N}{\tau}$$

where *N*, *D*, *x*, *y*, *t*, and  $\tau$  correspond to the number of excitons, diffusion coefficient, x coordinate, y coordinate, time, and lifetime of excitons, respectively. The differential equation can be solved numerically, yielding D values of 50, 15, and 30 cm<sup>2</sup>/s for I1, I2 and I3, respectively (for details of the calculation, please see Figure S6). These large diffusion constants are obiously consistent with mobile excitons rather than localized excitons. In addition, we have measured excitation power dependence of intensities of I1-I3 peaks to further exclude the possibility that the origin of  $I_1-I_3$  is bound excitons. As shown in Figure S7, intensities of  $I_1-I_3$  peaks show linear relations, where a constant  $\alpha$  in  $I_{ex} = c \times I_{laser}^{\alpha}$  (where  $I_{ex}$  is the intensity of interlayer exciton peak, c is a constant,  $I_{\text{laser}}$  is the intensity of the excitation laser) is 1.1, 0.91, and 0.97 for  $I_1$ ,  $I_2$ , and  $I_3$ , respectively. This linear relation is inconsistent to bound excitons because, in the case of bound excitons,  $\alpha$  should be much smaller than 1 due to the intensity saturation caused by limited number of bound centers.

To address the origin of the  $I_1-I_2$  peaks in detail, we calculated the electronic band structure of WS<sub>2</sub>/MoS<sub>2</sub> using density functional theory (DFT). We used a stacking angle of 60° in this calculation. As seen in the calculated band structure (shown in Figure 4a), the conduction band originates from MoS<sub>2</sub>, whose CBM is located at the K valley, whereas the valence band originates from both MoS<sub>2</sub> and WS<sub>2</sub> with VBM located at the  $\Gamma$  valley. This structure implies that photoexcited carriers should form interlayer excitons in WS<sub>2</sub>/MoS<sub>2</sub> after relaxation. Four valleys can contribute to optical transitions in this system, that is, the valleys located at the K and  $\Gamma$  points in the valence band and the valleys located at the K and Q points in the conduction band. The Q point is located between the K and  $\Gamma$  points in the Brillouin zone. One of the indicators for the origin of  $I_1 - I_3$  is their spectral shape. Table 1 lists the full width at half-maximum (fwhm) and (Gaussian component)/(Lorentzian component) ratios of  $I_1-I_3$  obtained through peak fitting with the Voigt function. As shown in this table, the fwhm and the (Gaussian component)/(Lorentzian component) ratio of  $I_1$  are much smaller than those of  $I_2$  and  $I_3$ . This strongly indicates that a broadening factor is involved in the I<sub>2</sub> and I<sub>3</sub> peaks, such as phonon emission and absorption. Considering

Table 1. Full Width at Half-Maximum and Ratio of Gaussian and Lorentzian Components of Interlayer Excitons Fitted with a Voigt Function

peak	fwhm/meV	ratio of Gaussian/Lorentzian fwhm
$I_1$	27	$3.7 \times 10^{-1}$
$I_2$	123	2.8
$I_3$	69	6.3

the energies of the K,  $\Gamma$ , and Q valleys, we conclude that I<sub>1</sub>, I<sub>2</sub>, and I<sub>3</sub> indicate direct K–K interlayer excitons, indirect Q– $\Gamma$ interlayer excitons, and indirect K– $\Gamma$  interlayer excitons, respectively. Although the conclusion that three transitions (K–K, K– $\Gamma$ , and Q– $\Gamma$ ) that should be the origin of the lowenergy PL peaks does not depend on detailed stacking configuration and interlayer distance used in DFT calculations, it should be noted that strict assignment of the peaks is contingent on a very accurate estimate of interlayer distance in WS<sub>2</sub>/MoS<sub>2</sub> in DFT calculations (please see Figure S8 and discussion therein). The temperature dependence of the peak positions of I<sub>1</sub>, I<sub>2</sub>, and I<sub>3</sub> is consistent with these assignments. As shown in Figure S3, the peak positions of I<sub>1</sub>–I<sub>3</sub> depend differently on temperature; this indicates that excitons corresponding to I<sub>1</sub>–I<sub>3</sub> originate from different valleys.

For further exploration of the origin of these excitonic peaks, we calculated the dielectric response  $\varepsilon(\omega)$  for both monolayers and the whole heterostructure. We solved the Bethe-Salpeter equation with  $G_0W_0$  to correctly determine the quasiparticle energies and electron-hole interactions in these excitonic systems. The imaginary part of the dielectric function  $\varepsilon$  is directly related to the optical spectra of the material; thus, peaks in  $Im(\varepsilon)$  are reflected exactly in the absorption spectra. The optical spectra calculated for the monolayers (Figure 4b) show the A exciton peak to be at ~1.85 and ~2.0 eV for  $MoS_2$  and WS<sub>2</sub>, respectively, which matches very well with the observed peaks from intralayer excitons (Figure 2a). The calculated binding energies for the A exciton peak are ~0.55 and ~0.45 eV for MoS<sub>2</sub> and WS<sub>2</sub>, respectively. In addition, the peak positions for the B and C excitons are in good agreement with those observed in previous studies.<sup>40,41</sup> The calculated absorption spectrum of the heterostructure shown in Figure 4b is not simply a superposition of those of the two monolayers. The peak positions in the heterostructure are slightly shifted when compared with the positions observed from individual monolayers. The absorption spectrum for the heterostructure also includes a distinctive feature corresponding to interlayer excitations. An interlayer excitonic peak can be observed in Figure 4b at 1.79-1.80 eV. This peak was also observed in a previous study on heterostructures.<sup>41</sup> The calculated oscillator strength for this interlayer exciton peak is found to be 1.3% of the intralayer MoS<sub>2</sub> exciton peak, which is explained by noting that the electrons and holes are separated into two different monolayers, thus reducing the overlap of the electron and hole wave functions. We calculated a quasiparticle band gap of 2.06 eV for the heterostructure that corresponds to an exciton binding energy of 0.27 eV for the interlayer exciton, which is similar in magnitude to that of the intralayer excitons. In this calculation, only optical responses corresponding to vertical transitions are represented, and the appearance of a single peak in the calculated optical spectra of  $WS_2/MoS_2$  is consistent with our conclusion that I1 originates from direct excitons, whereas I<sub>2</sub> and I<sub>3</sub> arise from indirect excitons.

Figure 5 plots time-resolved PL intensities of interlayer excitons measured at room temperature. Fitting the exper-



Figure 5. Time-resolved PL intensity of  $I_1$ ,  $I_2$ , and  $I_3$  of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN. Dashed line corresponds to the IRF.

imental data to a double exponential model yields relaxation times of the principal component of I<sub>1</sub> ( $\tau_1$ ), I<sub>2</sub> ( $\tau_2$ ), and I<sub>3</sub> ( $\tau_3$ ) of 116 ± 7, 210 ± 13, and 243 ± 12 ps, respectively.  $\tau_2$  and  $\tau_3$ are almost twice as long as  $\tau_1$ , and this is consistent with the peak assignment above; indirect interlayer excitons should have longer radiative decay lifetimes.<sup>21</sup> The room-temperature lifetime obtained is on the order of several hundreds of picoseconds, which is shorter than the lifetime of interlayer excitons previously reported in other heterostructures at low temperatures, including MoSe<sub>2</sub>/WSe<sub>2</sub>.<sup>1,21,22</sup> The PL lifetime of interlayer excitons has been proven to depend strongly on temperature, where the lifetime is significantly shorter at high temperatures.<sup>21,22</sup> Thus, the lifetime that we observed is consistent with previous results (additional data is shown in Figure S9).

The interlayer nature of this peak can be further confirmed by observing the dependence of emission intensity on excitation energy. Figure 6a shows a PLE intensity plot measured at 40 K with input power of 0.52–0.90  $\mu$ J/cm<sup>2</sup>. The PL spectra depend strongly on excitation energy. The region marked in red in Figure 6a plots the excitation energy dependence of emissions from a mixture of I<sub>2</sub> and I<sub>3</sub>. In this spectral region, three peaks appear close to 2.08, 2.24, and 2.47 eV excitation energies, as seen in Figure 6b. In order to trace the origin of the peaks in the PLE spectrum of the heterostructure, we compared positions of the regions I, II, and III with peak positions in calculated absorption spectra for individual monolayers. It is clear that both layers, MoS<sub>2</sub> and WS<sub>2</sub>, contribute individually to peaks in region I; namely, peaks in this region match with the WS<sub>2</sub> A exciton and MoS<sub>2</sub> B exciton. Region II matches with excitations in the MoS<sub>2</sub> layer, whereas region III is dominated by excitations from the WS<sub>2</sub> layer. Region I has greater intensity due to addition of excitations from both monolayers. This explains the large absorption cross section between 2.0 and 2.1 eV resulting in increased emission seen in Figure 6a. Due to type-II staggered band alignment and very rapid<sup>15,36</sup> charge transfer in WS<sub>2</sub>/ MoS<sub>2</sub>, interlayer excitons will form whenever individual monolayers are excited selectively, as electrons will transfer to MoS<sub>2</sub> when WS<sub>2</sub> is excited and holes will transfer to WS<sub>2</sub> when MoS<sub>2</sub> is excited. Therefore, interlayer excitons will appear and give distinct emissions in all three (I, II, and III) excitation regions. These considerations lead to the conclusion that the emission at 1.50-1.62 eV in Figure 6(b), with significant intensity in all three excitation regions, is an interlayer exciton peak. The emission around 1.73 eV (region of  $I_1$ ) in Figure 6b shows a similar tendency with excitation photon energy but has lower intensity, most likely due to different excited carrier relaxation pathways. We also calculated the joint density of states (JDOS), which can provide insights into carrier relaxation pathways.<sup>42</sup> Figure 6c shows the calculated IDOS. The JDOS corresponds to the band structure in Figure 4a. It



Figure 6. (a) Photoluminescence emission intensity plot for hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN at 40 K with an excitation power of 0.52–0.90  $\mu$ J/cm<sup>2</sup>. Region where the intensity of PL is over 8000 counts is colored red. (b) Integrated PL intensity of the interlayer exciton peaks at 1.70–1.77 eV (region of I<sub>1</sub>) and 1.50–1.62 eV (region of mixture of I<sub>2</sub> and I<sub>3</sub>). (c) Joint density of states of WS<sub>2</sub>/MoS<sub>2</sub> heterostructure obtained from DFT calculations. Some absorption peaks are due to excited states of excitons and thus cannot be captured by a single-particle description of  $\varepsilon_2$  under random phase approximation.

has been shifted upward by 0.39 eV, to match the average difference between the  $MoS_2$  and  $WS_2$  band gaps at the K point and the positions of the intralayer  $MoS_2$  and  $WS_2$  PL peaks that appear at 1.94 and 2.07 eV, respectively (Figure S10).

The observed intensity of the PLE spectrum shown in Figure 6b has three peaks at 2.08, 2.24, and 2.47 eV, and only the peak at 2.47 eV matches the features in the JDOS plot; similar tendency can also be seen in Figure 6c. This result shows that excitonic effects play an important role in the response of the WS<sub>2</sub>/MoS<sub>2</sub> heterostructure, and its absorption properties cannot be modeled appropriately with single-particle Kohn--Sham wavefunctions. The peak in JDOS is located in a bandnesting region, where the PL intensity from indirect excitons shows a pronounced peak. However, I<sub>1</sub> shows a lesspronounced peak in this energy region (Figure 6b), which suggests that indirect excitons are formed more efficiently than the direct excitons in this energy region. When a photoexcitation creates carriers in the band-nesting region, the created electrons and holes relax in opposite directions in kspace, and this may facilitate the formation of indirect excitons.<sup>42</sup> This factor may explain the observed difference in the PLE spectra measured from indirect and direct excitons.

## **CONCLUSION**

In summary, we have developed a fabrication method for hBNencapsulated TMD-based heterostructures in which we can control the stacking angle. Our method is based on the full drytransfer technique, which enables us to fabricate heterostructures with clean interfaces. The fabricated heterostructures, hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN or WS<sub>2</sub>/MoS<sub>2</sub>/hBN, produce PL spectra that include PL peaks from intralayer and interlayer excitons. The PL peak from interlayer excitons can be decomposed into three peaks, and observing these peaks was possible because of the suppression of inhomogeneous broadening of PL spectra. Optical measurements and theoretical analyses revealed that these three PL peaks originate from direct K-K interlayer excitons, indirect Q- $\Gamma$  interlayer excitons, and indirect K-F interlayer excitons. Our results suggest that vdW heterostructures composed of multivalley systems can host various interlayer excitons, which may have different exciton dispersions, decay lifetimes, and valley depolarization lifetimes. This is an important implication for the development of valleytronic devices with TMD-based vdW heterostructures.

#### **METHODS**

**CVD Growth of WS<sub>2</sub> on Sapphire (c-Plane).** We have grown monolayer WS<sub>2</sub> by the CVD method. We deposited tungsten (Nilaco, 99.95%) on a sapphire substrate, and elemental sulfur (Sigma-Aldrich, 99.98%) was supplied to the W-deposited substrate placed in a quartz tube. The inner diameter of quartz tube is 26 mm. Prior to the sulferization reaction, W deposited on the substrate was oxidized at 700 °C under air flow. The quartz tube was heated with a three-zone furnace at 221, 400, and 900 °C for 60 min under an Ar flow of 400 sccm. The sulfur- and W-deposited substrates were placed at the coolest and hottest zones, respectively.

**CVD Growth of MoS<sub>2</sub> on Exfoliated hBN.** We have grown  $MoS_2$  monolayers onto hBN by the CVD method. As precursors, elemental sulfur (Sigma-Aldrich, 99.98%) and molybdenum oxide (MoO<sub>3</sub>, Sigma-Aldrich, 99.5%) were used. As a substrate for synthesizing  $MoS_2$  monolayers, we prepared thin hBN flakes on a quartz substrate by the mechanical exfoliation method. Sulfur,  $MoO_3$ , and an hBN substrate were placed in a 26 mm inner diameter quartz tube. To avoid rapid sulfurization of  $MoO_3$ , the  $MoO_3$  was placed in an inner quartz

tube with an inner diameter of 10 mm. The quartz tubes were heated with a three-zone furnace at 200, 750, and 1100  $^{\circ}$ C for 20 min under an Ar flow of 200 sccm; sulfur, MoO<sub>3</sub>, and a substrate with hBN flakes were placed at the coolest, medium, and hottest zones, respectively.

Fabrication of hBN-Encapsulated Heterostructures. hBN flakes were prepared on 100 nm SiO<sub>2</sub>/Si substrates by the mechanical exfoliation method. One of the hBN flakes on a SiO<sub>2</sub>/Si was picked up by a PMMA (Microchem A11)/PDMS (Shin-Etsu Silicone KE-106) film on a glass slide, and then a monolayer WS<sub>2</sub> flake grown on a sapphire substrate was picked up with the hBN/PMMA/PDMS film. PMMA was used to improve the successful rate of the hBN pickup. The prepared stacked structure, WS2/hBN/PMMA/PDMS, was then transferred onto a MoS2/hBN on a quartz substrate to form a heterostructure, hBN/WS2/MoS2/hBN. To achieve sufficient interlayer contact, we heated the substrate during the transfer process, and the PMMA/PDMS film was detached from the prepared heterostructure by cooling the substrate. All the processes, pick-up and transfer process, were performed with a home-built manipulation system equipped with an optical microscope and stepping motor stages. After the fabrication of a heterostructure, we heated samples under vacuum at 200 °C over 10 h.

Photoluminescence and Raman Measurement. We obtained PL images by a fluorescence microscope (Leica TCS SP8 gSTED) at room temperature. To obtain the image, an excitation wavelength of 488 nm was used. Room-temperature PL and Raman spectra were measured by using a confocal Raman microscope (Renishaw InVia Raman and Horiba Jobin Yvon LabRAM HR-800) with 488 nm CW laser excitation (COHERENT Sapphire 488 LP). In PLE measurements and time-resolved PL measurements, we used a home-built microspectroscopy system equipped with a spectrometer (Princeton Instruments IsoPlane SCT320) and a supercontinuum laser system (NKT Photonics SuperK EXTREME); laser beam from the supercontinuum laser was monochromated by a spectrometer (Princeton Instruments SP2150). In low-temperature measurements, we placed a sample in a cryostat (CryoVac KONTI-Cryostat-Micro) with continuous flowing of liquid He or  $N_2$  under a vacuum of ~ $10^{-4}$ Pa; CrvoVac TIC 304-MA was used to control temperature. Objective lenses  $(50-100 \times \text{ and } 0.7-0.85 \text{ NA})$  were used for all measurements.

First-Principles Calculations. First-principles DFT calculations were performed using the Vienna Ab Initio Simulation Package.<sup>4</sup> Ion-electron interactions were represented by all-electron projectoraugmented wave potentials.<sup>44</sup> The generalized gradient approximation parametrized by Perdew-Burke-Ernzerhof45 was used to account for the electronic exchange and correlation. The wave functions were expanded in a plane wave basis with energy cutoff of 500 eV. The structure was relaxed until the components of Hellmann-Feynman forces on the atoms were less than  $10^{-4}$  eV/Å, and an optimized lattice constant of 3.18 Å was obtained for both MoS<sub>2</sub> and WS<sub>2</sub>. The heterostructure was constructed from the primitive cells of MoS<sub>2</sub> and WS<sub>2</sub> with the stacking similar to that found in 2H-MoS<sub>2</sub>. A vacuum of 20 Å was used in all the calculations. The interlayer spacing in the heterostructure was optimized using the optB86b-vdW^{46} functional to approximately account for dispersion interactions, and a value of 6.24 Å was obtained. Spin-orbit coupling was included in all the calculations. Optical spectra were calculated using single-shot  $G_0W_0$ procedure together with solution of the Bethe–Salpeter equation in the Tamm–Dancoff approximation.<sup>47,48</sup> This technique correctly accounts for electron-hole interaction necessary to obtain an accurate excitonic spectra.  $\Gamma\text{-centered}$  grids of 18  $\times$  18  $\times$  1 and 15  $\times$  15  $\times$  1 were used to sample the Brillouin zone for monolayers and heterostructures, respectively. A total of 182 bands, which includes 156 empty bands, was used for monolayers, whereas 280 bands with 224 empty bands were included for the heterostructure. These parameters were optimized to obtain a converged optical spectrum.

## ASSOCIATED CONTENT

## **S** Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsnano.7b08253.

Characterization of CVD-grown monolayer  $WS_2$  and  $MoS_{2\nu}$  low-frequency Raman spectrum of hBN/WS<sub>2</sub>/ $MoS_2/hBN$ , characterization of CVD-grown  $WS_2/MoS_2/hBN$ , statistics on the peak position of the low-energy PL peaks, PL spectra of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN with different stacking angle, details on the determination of the diffusion constant, excitation power dependence of the low-energy PL peaks, DFT calculation of transition energies of  $WS_2/MoS_2$ , another example of time-resolved PL intensity of hBN/WS<sub>2</sub>/MoS<sub>2</sub>/hBN, and a PL spectrum from intralayer excitons at low temperature (PDF)

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#### Notes

The authors declare no competing financial interest.

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